

# FDS3812

# 80V N-Channel Dual PowerTrench® MOSFET

## **General Description**

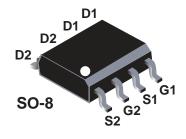
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

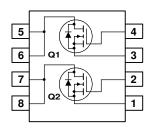
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable  $R_{\scriptscriptstyle DS(ON)}$  specifications. The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

### **Features**

3.4 A, 80 V.  $R_{DS(ON)} = 74 \ m\Omega \ @V_{GS} = 10 \ V$   $R_{DS(ON)} = 84 \ m\Omega \ @V_{GS} = 6 \ V$ 

- · Fast switching speed
- Low gate charge (13nC typ)
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- · High power and current handling capability





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		80	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	3.4	A
	- Pulsed		20	
P <sub>D</sub>	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1.0	
		(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +175	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity	
FDS3812 FDS3812		13"			

Symbol	Parameter	<b>Test Conditions</b>	Min	Тур	Max	Units
Drain-Sc	ource Avalanche Ratings (Note	2)	1		ı	ı
W <sub>DSS</sub>	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 40 \text{ V},  I_D = 3.4 \text{ A}$			90	mJ
I <sub>AR</sub>	Maximum Drain-Source Avalanche Current				3.4	Α
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C		80		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}$ $V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	2.4	4	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C		-6		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_D = 3.4 \text{ A} \\ V_{GS} = 6.0 \text{ V}, \qquad I_D = 3.2 \text{ A} \\ V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}, T_J = 125^{\circ}\text{C}$		53 58 94	74 84 140	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	20			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 3.4 \text{ A}$		14		S
Dynamic	Characteristics				l	l
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 40 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		634		pF
Coss	Output Capacitance	f = 1.0 MHz		58		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			28		pF
Switchin	g Characteristics (Note 2)	1	1	ı	I	
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, \qquad I_{D} = 1 \text{ A},$		7	14	ns
tr	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		3	6	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			24	28	ns
t <sub>f</sub>	Turn-Off Fall Time			4	8	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 40 \text{ V}, \qquad I_{D} = 3.4 \text{ A},$		13	18	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		2.4		nC
$Q_{gd}$	Gate-Drain Charge	7		2.8		nC
Drain_So	ource Diode Characteristics a	and Maximum Ratings				
I <sub>s</sub>	Maximum Continuous Drain-Source	•			1.3	Α
V <sub>SD</sub>	Drain-Source Diode Forward	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.3 A (Note 2)		0.8	1.2	V

#### Notes

R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of
the drain pins. R<sub>BJC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.



a) 78°C/W when mounted on a 1in² pad of 2 oz copper



b) 125°C/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper





c) 135°C/W when mounted on a minimum pad.

<sup>2.</sup> Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

# **Typical Characteristics**

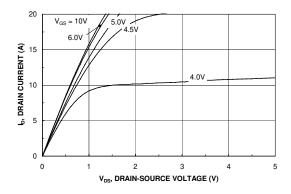
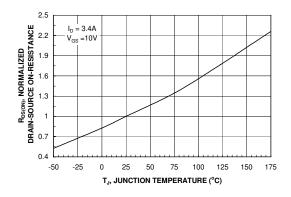


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



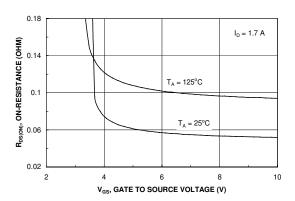
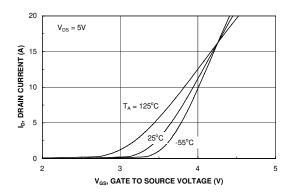


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



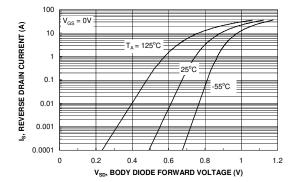
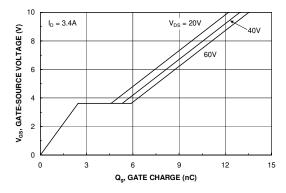


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



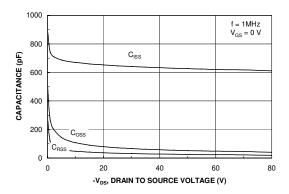
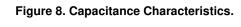
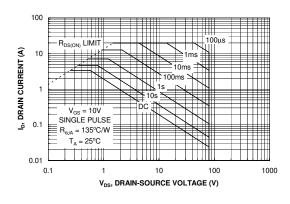


Figure 7. Gate Charge Characteristics.





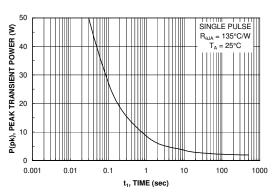


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

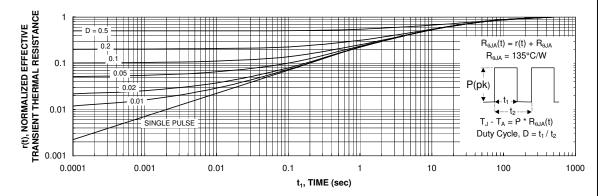


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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